

Insulated Gate Bipolar Transistor (Ultrafast IGBT), 90 A



PRODUCT SUMMARY				
V _{CES}	1200 V			
I _C DC	90 A at 90 °C			
V _{CE(on)} typical at 75 A, 25 °C	3.3 V			
Speed	8 kHz to 30 kHz			
Package	SOT-227			
Circuit	Single switch diode			

FEATURES

- NPT Gen 5 IGBT technology
- Square RBSOA
- HEXFRED® low Q_{rr}, low switching energy
- Positive V_{CE(on)} temperature coefficient
- · Fully isolated package
- Very low internal inductance (≤ 5 nH typical)
- · Industry standard outline
- UL approved file E78996



· Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

BENEFITS

- · Designed for increased operating efficiency in power conversion: UPS, SMPS, welding, induction heating
- Easy to assemble and parallel
- · Direct mounting on heatsink
- Plug-in compatible with other SOT-227 packages
- · Low EMI, requires less snubbing

ABSOLUTE MAXIMUM RATINGS					
PARAMETER	SYMBOL	TEST CONDITIONS	MAX.	UNITS	
Collector to emitter voltage	V _{CES}		1200	V	
Continuous collector current	I _C ⁽¹⁾	T _C = 25 °C	149		
Continuous collector current	IC (')	T _C = 90 °C	90		
Pulsed collector current	I _{CM}		200	A	
Clamped inductive load current	I _{LM}		200	A	
Diode continuous forward current		T _C = 25 °C	76		
	l _F	T _C = 90 °C	46		
Gate to emitter voltage	V _{GE}		± 20	V	
Davier dissipation ICDT	р	T _C = 25 °C	862		
Power dissipation, IGBT	P _D	T _C = 90 °C	414	w	
	Б	T _C = 25 °C	357	VV	
Power dissipation, diode	P _D	T _C = 90 °C	171		
Isolation voltage	V _{ISOL}	Any terminal to case, t = 1 min	2500	V	

Note

⁽¹⁾ Maximum collector current admitted is 100 A, to do exceed the maximum temperature of terminals



ELECTRICAL SPECIFICATIONS (T _J = 25 °C unless otherwise specified)						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Collector to emitter breakdown voltage	V _{BR(CES)}	V _{GE} = 0 V, I _C = 250 μA	1200	-	-	
	V _{CE(on)}	$V_{GE} = 15 \text{ V}, I_{C} = 75 \text{ A}$	-	3.3	3.8	v
Collector to emitter voltage		V _{GE} = 15 V, I _C = 75 A, T _J = 125 °C	-	3.6	3.9	
		V _{GE} = 15 V, I _C = 75 A, T _J = 150 °C	-	3.7	-	v
Cata threshold voltage	V _{GE(th)}	$V_{CE} = V_{GE}$, $I_C = 250 \mu A$	4	5	6	
Gate threshold voltage		$V_{CE} = V_{GE}$, $I_C = 250 \mu A$, $T_J = 125 ^{\circ}C$	-	3.2	-	
Temperature coefficient of threshold voltage	$V_{GE(th)}/\Delta T_J$	$V_{CE} = V_{GE}$, $I_{C} = 1$ mA (25 °C to 125 °C)	-	-12	-	mV/°C
		V _{GE} = 0 V, V _{CE} = 1200 V	-	7	250	μA
Collector to emitter leakage current	I _{CES}	V _{GE} = 0 V, V _{CE} = 1200 V, T _J = 125 °C	-	1.4	10	A
		V _{GE} = 0 V, V _{CE} = 1200 V, T _J = 150 °C	-	6.5	20	mA
	V _{FM}	V _{GE} = 0 V, I _F = 75 A	-	3.4	5.0	
Forward voltage drop, diode		V _{GE} = 0 V, I _F = 75 A, T _J = 125 °C	-	3.2	5.2	V
		V _{GE} = 0 V, I _F = 75 A, T _J = 150 °C	-	3.05	-	
Gate to emitter leakage current	I _{GES}	V _{GE} = ± 20 V	-	-	± 250	nA

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNITS
Total gate charge (turn-on)	Qg			-	690	-	
Gate to emitter charge (turn-on)	Q _{ge}	$I_C = 50 \text{ A}, V_{CC} = 600 \text{ V}, \text{ V}$	_{'GE} = 15 V	-	65	-	nC
Gate to collector charge (turn-on)	Q _{gc}			-	250	-	1
Turn-on switching loss	E _{on}			-	1.2	-	
Turn-off switching loss	E _{off}			-	2.1	-	mJ
Total switching loss	E _{tot}	I _C = 75 A, V _{CC} = 600 V,		-	3.3	-	
Turn-on delay time	t _{d(on)}	$V_{GE} = 15 \text{ V}, R_g = 5 \Omega,$		-	250	-	ns
Rise time	t _r	$L = 500 \mu H, T_J = 25 °C$		-	38	-	
Turn-off delay time	t _{d(off)}		Energy losses include tail and	-	280	-	
Fall time	t _f			-	90	-	
Turn-on switching loss	E _{on}		diode recovery Diode used HFA16PB120	-	1.7	-	mJ
Turn-off switching loss	E _{off}	I_{C} = 75 A, V_{CC} = 600 V, V_{GE} = 15 V, R_{g} = 5 Ω , L = 500 μ H, T_{J} = 125 °C		-	4.08	-	
Total switching loss	E _{tot}			-	5.78	-	
Turn-on delay time	t _{d(on)}			-	245	-	
Rise time	t _r			-	48	-	
Turn-off delay time	t _{d(off)}			-	280	-	ns
Fall time	t _f			-	140	-	
Reverse bias safe operating area	RBSOA	T_J = 150 °C, I_C = 200 A, R_g = 22 Ω , V_{GE} = 15 V to 0 V, V_{CC} = 900 V, V_P = 1200 V, L = 500 μ H			Fullso	quare	
Diode reverse recovery time	t _{rr}	$I_F = 50 \text{ A}, dI_F/dt = 200 \text{ A/}\mu\text{s}, V_R = 200 \text{ V}$		-	140	-	ns
Diode peak reverse current	I _{rr}			-	13	-	Α
Diode recovery charge	Q _{rr}			-	860	-	nC
Diode reverse recovery time	t _{rr}	$I_F = 50 \text{ A}, \text{ d}I_F/\text{d}t = 200 \text{ A/}\mu\text{s}, \text{ V}_R = 200 \text{ V}, \\ T_J = 125 ^{\circ}\text{C}$		-	210	-	ns
Diode peak reverse current	I _{rr}			-	19	-	Α
Diode recovery charge	Q _{rr}			-	1880	-	nC



THERMAL AND MECHANICAL SPECIFICATIONS						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Junction and storage temperature range	T _J , T _{Stg}		-40	-	150	°C
Junction to case			-	-	0.145	
Diode	R _{thJC}		-	-	0.35	°C/W
Case to heatsink	R _{thCS}	Flat, greased surface	-	0.05	-	
Weight			-	30	-	g
Mounting torque			-	-	1.3	Nm
Case style		SOT-227	7			

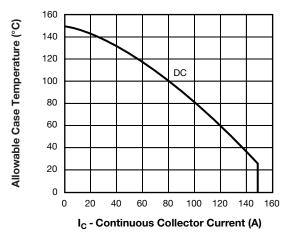


Fig. 1 - Maximum DC IGBT Collector Current vs.

Case Temperature

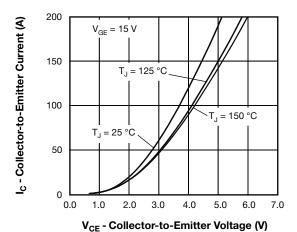


Fig. 2 - Typical Collector to Emitter Current Output Characteristics of IGBT

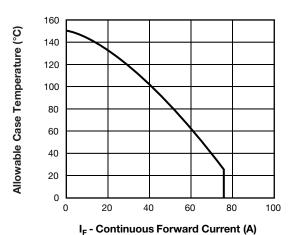


Fig. 3 - Allowable Forward Current vs. Case Temperature Diode Leg

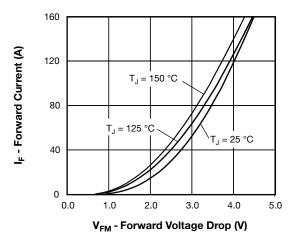


Fig. 4 - Typical Diode Forward Voltage Drop Characteristics

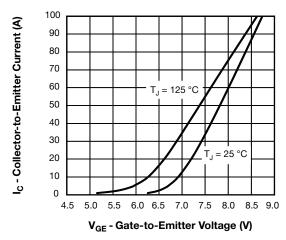


Fig. 5 - Typical IGBT Transfer Characteristics

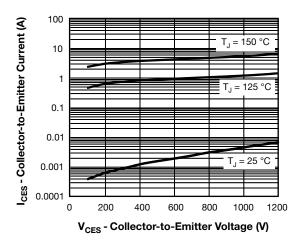


Fig. 6 - Typical IGBT Zero Gate Voltage Collector Current

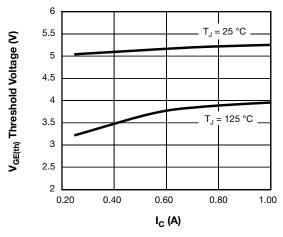


Fig. 7 - Typical IGBT Threshold Voltage

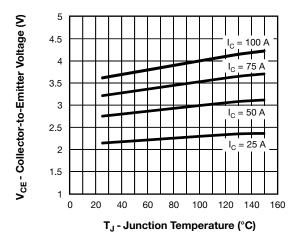


Fig. 8 - Typical IGBT Collector to Emitter Voltage vs. Junction Temperature, $V_{\text{GE}} = 15 \text{ V}$

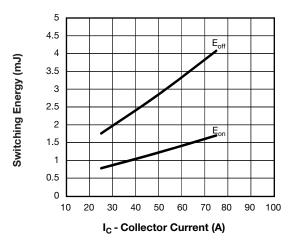


Fig. 9 - Typical IGBT Energy Losses vs. I $_{C}$ T $_{J}$ = 125 °C, L = 500 μ H, V $_{CC}$ = 600 V, R $_{q}$ = 5 Ω , V $_{GE}$ = 15 V, Diode used HFA16PB120

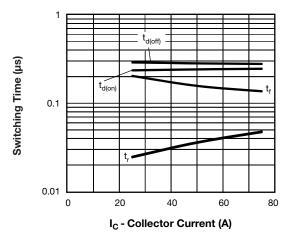


Fig. 10 - Typical IGBT Switching Time vs. I_C T_J = 125 °C, L = 500 μ H, V_{CC} = 600 V, R_g = 5 Ω , V_{GE} = 15 V, Diode used HFA16PB120

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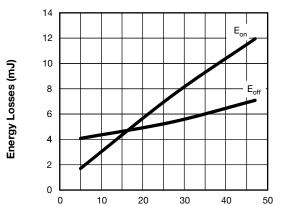


Fig. 11 - Typical IGBT Energy Loss vs. R $_g$, T $_J$ = 125 °C, I $_C$ = 75 A, L = 500 μ H, V $_{CC}$ = 600 V, V $_{GE}$ = 15 V, Diode used HFA16PB120

 $\mathbf{R_g}$ (Ω)

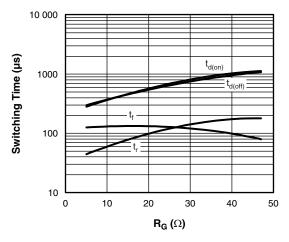


Fig. 12 - Typical IGBT Switching Time vs. R_g T_J = 125 °C, L = 500 μ H, V_{CC} = 600 V, R_g = 5 Ω , V_{GE} = 15 V

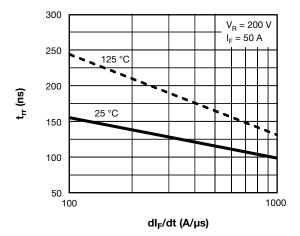


Fig. 13 - Typical t_{rr} Diode vs. dI_F/dt V_{RR} = 200 V, I_F = 50 A

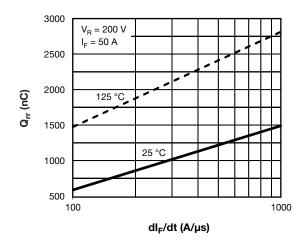


Fig. 14 - Stored Charge vs. dl_F/dt of Diode

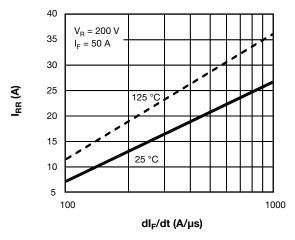


Fig. 15 - Typical Reverse Recovery Current vs. dl_F/dt of Diode



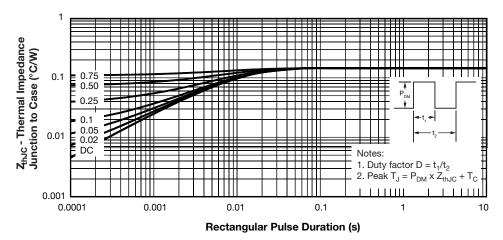


Fig. 16 - Maximum Thermal Impedance Z_{thJC} Characteristics (IGBT)

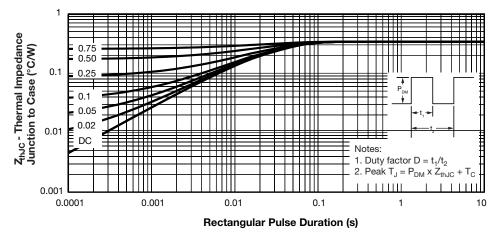


Fig. 17 - Maximum Thermal Impedance Z_{thJC} Characteristics (Diode)

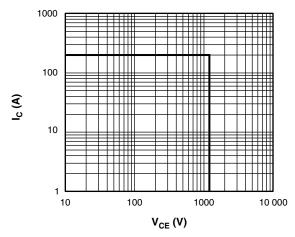
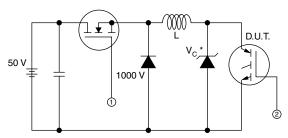


Fig. 18 - IGBT Reverse Bias SOA, TJ = 150 °C, V_{GE} = 15 V,





- * Driver same type as D.U.T.; V_C = 80 % of $V_{ce(max.)}$ * Note: Due to the 50 V power supply, pulse width and inductor will increase to obtain Id

Fig. 19a - Clamped Inductive Load Test Circuit

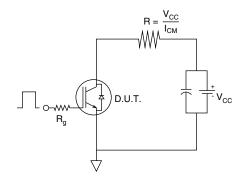


Fig. 19b - Pulsed Collector Current Test Circuit

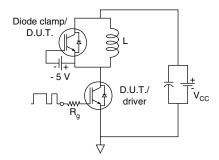


Fig. 20a - Switching Loss Test Circuit

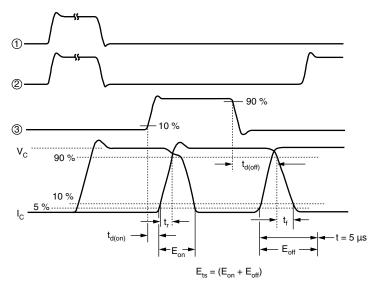
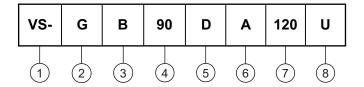


Fig. 20b - Switching Loss Waveforms Test Circuit



ORDERING INFORMATION TABLE

Device code



- 1 Vishay Semiconductors product
- Insulated Gate Bipolar Transistor (IGBT)
- B = IGBT Generation 5
- Current rating (90 = 90 A)
- Circuit configuration (D = Single switch with antiparallel diode)
- Package indicator (A = SOT-227)
- 7 Voltage rating (120 = 1200 V)
- Speed/type (U = Ultrafast IGBT)

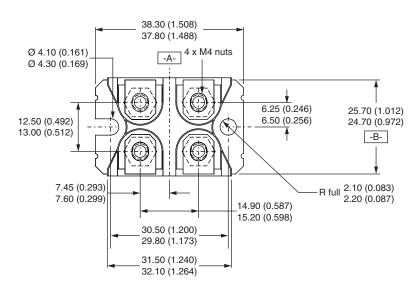
CIRCUIT CONFIGURATION					
CIRCUIT	CIRCUIT CONFIGURATION CODE	CIRCUIT DRAWING			
Single switch with antiparallel diode	D	Lead Assignment 4 1, 4 (E)			

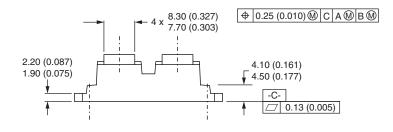
LINKS TO RELATED DOCUMENTS				
Dimensions <u>www.vishay.com/doc?95423</u>				
Packaging information	www.vishay.com/doc?95425			

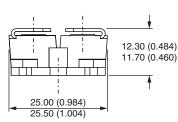


SOT-227 Generation II

DIMENSIONS in millimeters (inches)







Note

• Controlling dimension: millimeter



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